

GaAs INTEGRATED CIRCUIT μ PG2008TB

L, S-BAND SPDT SWITCH

DESCRIPTION

The μ PG2008TB is an L, S-band SPDT (Single Pole Double Throw) GaAs FET switch which was developed for digital cellular, cordless telephone and other L, S-band wireless application. The device can operate from 500 MHz to 2.5 GHz, having the low insertion loss. It housed in an original 6-pin super minimold package that is smaller than usual 6-pin minimold easy to install and contributes to miniaturizing the system.

FEATURES

Low insertion loss : Lins = 0.3 dB TYP. @ V_{cont} = +3.0 V/0 V, f = 1 GHz

LINS = 0.4 dB TYP. @ $V_{cont} = +3.0 \text{ V/0 V}$, f = 2 GHz

• High isolation : ISL = 27 dB TYP. @ V_{cont} = +3.0 V/0 V, f = 0.5 to 2.0 GHz

6-pin super minimold package (2.0 × 1.25 × 0.9 mm)

APPLICATION

· L, S-band digital cellular or cordless telephone

Buletooth[™], W-LAN and WLL applications

ORDERING INFORMATION

Part Number	Package	Marking	Supplying Form
μPG2008TB-E3	6-pin super minimold	G3D	 Embossed tape 8 mm wide Pin 1, 2, 3 face the perforation side of the tape Qty 3 kpcs/reel

Remark To order evaluation samples, contact your nearby sales office.

Part number for sample order: μPG2008TB

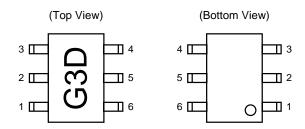
Caution Observe precautions when handling because these devices are sensitive to electrostatic discharge.

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Not all devices/types available in every country. Please check with local NEC Compound Semiconductor Devices representative for availability and additional information.

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PIN CONNECTIONS



Pin No.	Pin Name
1	OUT1
2	GND
3	OUT2
4	V _{cont2}
5	IN
6	V _{cont1}

ABSOLUTE MAXIMUM RATINGS (T_A = +25°C, unless otherwise specified)

Parameter	Symbol	Ratings	Unit
Control Voltage 1, 2	Vcont1, 2	-6.0 to +6.0 Note	V
Input Power	Pin	+28	dBm
Total Power Dissipation	Ptot	0.15	W
Operating Ambient Temperature	TA	-45 to +85	°C
Storage Temperature	Tstg	-55 to +150	°C

Note $|V_{cont1}-V_{cont2}| \le 6.0 \text{ V}$

RECOMMENDED OPERATING RENGE (TA = +25°C)

Parameter	Symbol	MIN.	TYP.	MAX.	Unit
Control Voltage (High)	V _{cont(H)}	+2.5	+3.0	+5.3	V
Control Voltage (Low)	V _{cont(L)}	-0.2	0	+0.2	V

ELECTRICAL CHARACTERISTICS

(TA = +25°C, V_{cont1} = +3 V, V_{cont2} = 0 V or V_{cont1} = 0 V, V_{cont2} = +3 V, Z_0 = 50 Ω , Off chip DC blocking capacitors value; 51 pF, unless otherwise specified)

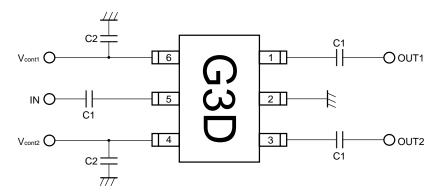
Parameter	Symbol	Test Conditions	MIN.	TYP.	MAX.	Unit
Insertion Loss	Lins	f = 0.5 to 1.0 GHz	-	0.30	0.55	dB
		f = to 2.0 GHz	-	0.40	0.65	dB
		f = to 2.5 GHz	-	-	0.90	dB
Isolation	ISL	f = 0.5 to 2.0 GHz	22	27	_	dB
		f = to 2.5 GHz	18	-	-	dB
Input Return Loss	RLin	f = 0.5 to 2.0 GHz	13	19	-	dB
		f = to 2.5 GHz	11	-	-	dB
Output Return Loss	RLout	f = 0.5 to 2.0 GHz	13	19	-	dB
		f = to 2.5 GHz	11	-	_	dB
Input Power at 0.1 dB	Pin(0.1 dB)	f = 1.0 GHz, V _{cont} = +3 V/0 V	_	23.0	_	dBm
Compression Point Note						
Input Power at 1 dB	Pin(1 dB)	f = 1.0 GHz, V _{cont} = +3 V/0 V	22.0	26.5	_	dBm
Compression Point Note						
Switching Speed	tsw		-	50	200	ns
Control Current	Icont	V _{cont} = +3 V/0 V, RF Non	-	0.5	10	μΑ

Note P_{in(0.1 dB)} or P_{in(1 dB)} is measured the input power level when the insertion loss increase more 0.1 dB or 1 dB than that of linear range. All other characteristics are measured in linear range.

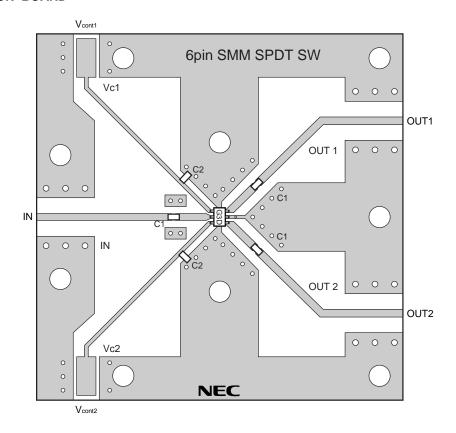
- Cautions 1. When the μ PG2008TB is used it is necessary to use DC blocking capacitors for No.1 (OUT1), No.3 (OUT2) and No.5 (IN). The value of DC blocking capacitors should be chosen to accommodate the frequency of operation, bandwidth, switching speed and the condition with actual board of your system.
 - The range of recommended DC blocking capacitor value is less than 100 pF.
 - 2. The distance between IC's GND pin and ground pattern of substrate should be as shorter as possible to avoid parasitic parameters.

EVALUATION CIRCUIT

 $V_{cont1} = 3.0 \text{ V}$, $V_{cont2} = 0 \text{ V}$ or $V_{cont2} = 0 \text{ V}$, $V_{cont1} = 3.0 \text{ V}$, off chip DC blocking capacitors value C1 = 51 pF, C2 = 1 000 pF (Bypass), using NEC standard evaluation board.



EVALUATION BOARD



TRUTH TABLE

V _{cont1}	V _{cont2}	IN-OUT1	IN-OUT2
Low	High	ON	OFF
High	Low	OFF	ON

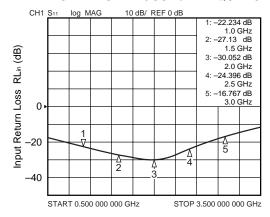
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TYPICAL CHARACTERISTICS

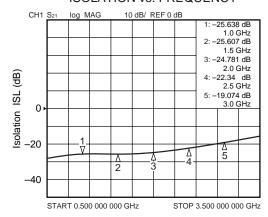
TEST CONDITION: TA = $+25^{\circ}$ C, V_{cont1/2} = 0 V/3.0 V, P_{in} = 0 dBm, OUT2 side is 50 Ω termination

INPUT RETURN LOSS vs. FREQUENCY



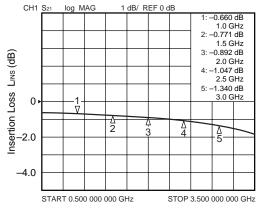
Frequency f(GHz)

ISOLATION vs. FREQUENCY



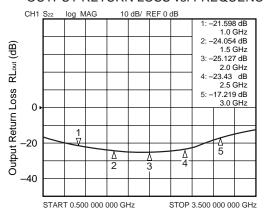
Frequency f(GHz)

INSERTION LOSS vs. FREQUENCY



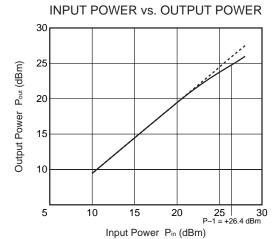
Frequency f(GHz)

OUTPUT RETURN LOSS vs. FREQUENCY



Frequency f(GHz)

TEST CONDITION: $T_A = +25$ °C, f = 1 GHz, $V_{cont1/2} = 0$ V3.0 V, OUT2 side is termination

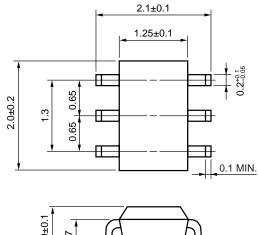


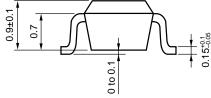
Remark The graphs indicate nominal characteristics.

PACKAGE DIMENSIONS

NEC

6-PIN SUPER MINIMOLD (UNIT: mm)





RECOMMENDED SOLDERING CONDITIONS

This product should be soldered and mounted under the following recommended conditions. For soldering methods and conditions other than those recommended below, contact your nearby sales office.

Soldering Method	Soldering Conditions		Condition Symbol
Infrared Reflow	Peak temperature (package surface temperature) Time at peak temperature Time at temperature of 220°C or higher Preheating time at 120 to 180°C Maximum number of reflow processes Maximum chlorine content of rosin flux (% mass)	: 260°C or below : 10 seconds or less : 60 seconds or less : 120±30 seconds : 3 times : 0.2%(Wt.) or below	IR260
VPS	Peak temperature (package surface temperature) Time at temperature of 200°C or higher Preheating time at 120 to 150°C Maximum number of reflow processes Maximum chlorine content of rosin flux (% mass)	: 215°C or below : 25 to 40 seconds : 30 to 60 seconds : 3 times : 0.2%(Wt.) or below	VP215
Wave Soldering	Peak temperature (molten solder temperature) Time at peak temperature Preheating temperature (package surface temperature) Maximum number of flow processes Maximum chlorine content of rosin flux (% mass)	: 260°C or below : 10 seconds or less : 120°C or below : 1 time : 0.2%(Wt.) or below	WS260
Partial Heating	Peak temperature (pin temperature) Soldering time (per side of device) Maximum chlorine content of rosin flux (% mass)	: 350°C or below : 3 seconds or less : 0.2%(Wt.) or below	HS350

Caution Do not use different soldering methods together (except for partial heating).

NEC μ PG2008TB

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SAFETY INFORMATION ON THIS PRODUCT

Caution

GaAs Products

The product contains gallium arsenide, GaAs.

GaAs vapor and powder are hazardous to human health if inhaled or ingested.

- Do not destroy or burn the product.
- Do not cut or cleave off any part of the product.
- . Do not crush or chemically dissolve the product.
- Do not put the product in the mouth.

Follow related laws and ordinances for disposal. The product should be excluded from general industrial waste or household garbage.

▶Business issue

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▶ Technical issue

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